



FCC Part 1 Subpart I  
FCC Part 2 Subpart J  
INDUSTRY CANADA RSS 102 ISSUE 5

RF EXPOSURE REPORT

FOR

SMART LOCK

MODEL NUMBERS: BLB0

FCC ID: 2AMVI-G1

IC ID: 22940-G1

REPORT NUMBER: 11854771-E3V2

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## 1. ATTESTATION OF TEST RESULTS

**COMPANY NAME:** GATE LABS, INC.  
379 CLEMENTINA ST, SUITE A  
SAN FRANCISCO, CA, 94103 USA

**EUT DESCRIPTION:** SMART LOCK

**MODEL:** BLB0

**DATE TESTED:** N/A

APPLICABLE STANDARDS	
STANDARD	TEST RESULTS
FCC PART 1 SUBPART I & PART 2 SUBPART J	Pass
INDUSTRY CANADA RSS 102 ISSUE 5	Pass

UL Verification Services Inc. calculated the RF Exposure of the above equipment in accordance with the requirements set forth in the above standards, using test results reported in the test report documents referenced below and/or documentation furnished by the applicant. All indications of Pass/Fail in this report are opinions expressed by UL Verification Services Inc. based on interpretations of these calculations. The results show that the equipment is capable of demonstrating compliance with the requirements as documented in this report.

**Note:** The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Verification Services Inc. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Verification Services Inc. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, any agency of the Federal Government, or any agency of the U.S. government.

Approved & Released For  
UL Verification Services Inc. By:



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Francisco de Anda  
CONSUMER TECHNOLOGY DIVISION  
Program Manager  
UL Verification Services Inc.

## 2. TEST METHODOLOGY

All calculations were made in accordance with FCC OET Bulletin 65 Edition 97-01 and IC Safety Code 6.

## 3. REFERENCES

All measurements were made as documented in test report UL Verification Services Inc. Document "11854771-E1V2 FCC DTS Report" for operation in the 2.4 GHz band.

Duty cycle data is excerpted from the applicable test reports.

Output power is excerpted from the applicable test reports and Antenna gain data is excerpted from product documentation provided by the applicant.

## 4. FACILITIES AND ACCREDITATION

The test sites and measurement facilities used to collect data are located at 47173 Benicia Street, Fremont, California, USA.

UL Verification Services Inc. is accredited by NVLAP, Laboratory Code 200065-0.

## 5. DESCRIPTION OF EUT

The EUT is a mobile wireless Smart Lock.

## 6. MAXIMUM PERMISSIBLE RF EXPOSURE

### 6.1. FCC RULES

§1.1310 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of §2.1093 of this chapter.

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm <sup>2</sup> )	Averaging time (minutes)
<b>(A) Limits for Occupational/Controlled Exposure</b>				
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f <sup>2</sup>	6
30-300	61.4	0.163	1.0	6
300-1,500			f/300	6
1,500-100,000			5	6
<b>(B) Limits for General Population/Uncontrolled Exposure</b>				
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f <sup>2</sup>	30
30-300	27.5	0.073	0.2	30
300-1,500			f/1500	30
1,500-100,000			1.0	30

f = frequency in MHz

\* = Plane-wave equivalent power density

#### Notes:

- (1) Occupational/controlled exposure limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when a person is transient through a location where occupational/controlled limits apply provided he or she is made aware of the potential for exposure.
- (2) General population/uncontrolled exposure limits apply in situations in which the general public may be exposed, or in which persons who are exposed as a consequence of their employment may not be fully aware of the potential for exposure or cannot exercise control over their exposure

## 6.2. IC RULES

IC Safety Code 6 (2015), Section 2.2.2: To ensure compliance with the basic restrictions outlined in Section 2.1, at frequencies between 10 MHz and 300 GHz, the reference levels for electric- and magnetic-field strength and power density must be complied with.

**TABLE 5:** Reference Levels for Electric Field Strength, Magnetic Field Strength and Power Density in Uncontrolled Environments

Frequency (MHz)	Electric Field Strength ( $E_{RL}$ ), (V/m, RMS)	Magnetic Field Strength ( $H_{RL}$ ), (A/m, RMS)	Power Density ( $S_{RL}$ ), (W/m <sup>2</sup> )	Reference Period (minutes)
10–20	27.46	0.0728	2	6
20–48	$58.07 / f^{0.25}$	$0.1540 / f^{0.25}$	$8.944 / f^{0.5}$	6
48–300	22.06	0.05852	1.291	6
300–6000	$3.142 f^{0.3417}$	$0.008335 f^{0.3417}$	$0.02619 f^{0.6834}$	6
6000–15000	61.4	0.163	10	6
15000–150000	61.4	0.163	10	$616000 / f^{1.2}$
150000–300000	$0.158 f^{0.5}$	$4.21 \times 10^{-4} f^{0.5}$	$6.67 \times 10^{-5} f$	$616000 / f^{1.2}$

Frequency,  $f$ , is in MHz.

**TABLE 6:** Reference Levels for Electric Field Strength, Magnetic Field Strength and Power Density in Controlled Environments

Frequency (MHz)	Electric Field Strength ( $E_{RL}$ ), (V/m, RMS)	Magnetic Field Strength ( $H_{RL}$ ), (A/m, RMS)	Power Density, ( $S_{RL}$ ), (W/m <sup>2</sup> )	Reference Period (minutes)
10–20	61.4	0.163	10	6
20–48	$129.8 / f^{0.25}$	$0.3444 / f^{0.25}$	$44.72 / f^{0.5}$	6
48–100	49.33	0.1309	6.455	6
100–6000	$15.60 f^{0.25}$	$0.04138 f^{0.25}$	$0.6455 f^{0.5}$	6
6000–15000	137	0.364	50	6
15000–150000	137	0.364	50	$616000 / f^{1.2}$
150000–300000	$0.354 f^{0.5}$	$9.40 \times 10^{-4} f^{0.5}$	$3.33 \times 10^{-4} f$	$616000 / f^{1.2}$

Frequency,  $f$ , is in MHz.

### NOTES FOR TABLES 5 AND 6:

1. For exposures shorter than the reference period, field strengths may exceed the reference levels, provided that the time average of the squared value of the electric or magnetic field strength over any time period equal to the reference period shall not exceed  $E_{RL}^2$  or  $H_{RL}^2$ , respectively. For exposures longer than the reference period, including indefinite exposures, the time average of the squared value of the electric or magnetic field strength over any time period equal to the reference period shall not exceed  $E_{RL}^2$  or  $H_{RL}^2$ , respectively.

### 6.3. EQUATIONS

#### POWER DENSITY

Power density is given by:

$$S = \text{EIRP} / (4 * \pi * D^2)$$

Where

S = Power density in mW/cm<sup>2</sup>

EIRP = Equivalent Isotropic Radiated Power in mW

D = Separation distance in cm

Power density in units of mW/cm<sup>2</sup> is converted to units of W/m<sup>2</sup> by multiplying by 10.

#### DISTANCE

Distance is given by:

$$D = \sqrt{(\text{EIRP} / (4 * \pi * S))}$$

Where

D = Separation distance in cm

EIRP = Equivalent Isotropic Radiated Power in mW

S = Power density in mW/cm<sup>2</sup>

#### SOURCE-BASED DUTY CYCLE

Where applicable (for example, multi-slot cell phone applications) a duty cycle factor may be applied.

$$\text{Source-based time-averaged EIRP} = (\text{DC} / 100) * \text{EIRP}$$

Where

DC = Duty Cycle in %, as applicable

EIRP = Equivalent Isotropic Radiated Power in W

### **MIMO AND COLOCATED TRANSMITTERS (IDENTICAL LIMIT FOR ALL TRANSMITTERS)**

For multiple chain devices, and colocated transmitters operating simultaneously in frequency bands where the limit is identical, the total power density is calculated using the total EIRP obtained by summing the EIRP (in linear units) of each transmitter.

Total EIRP = (EIRP1) + (EIRP2) + ... + (EIRPn)

where

EIRPx = Source-based time-averaged EIRP of chain x or transmitter x

The total EIRP is then used to calculate the Power Density or the Distance as applicable.

### **MIMO AND COLOCATED TRANSMITTERS**

For multiple colocated transmitters operating simultaneously in frequency bands where different limits apply:

The Power Density at the specified separation distance is calculated for each transmitter chain or transmitter.

The fraction of the exposure limit is calculated for each chain or transmitter as (Power Density of chain or transmitter) / (Limit applicable to that chain or transmitter).

The fractions are summed.

Compliance is established if the sum of the fractions is less than or equal to one.

## 6.4. IC EXEMPTION

### INDUSTRY CANADA EXEMPTION

RSS-102 Clause 2.5.2 RF exposure evaluation is required if the separation distance between the user and the device's radiating element is greater than 20 cm, except when the device operates as follows:

- at or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than  $1.31 \times 10^{-2} f^{0.6834}$  W (adjusted for tune-up tolerance), where  $f$  is in MHz;

## 7. RF EXPOSURE RESULTS

In the table(s) below, Power and Gain are entered in units of dBm and dBi respectively and conversions to linear forms are used for the calculations.

(Single chain transmitters, no colocation, MPE distance > 20 cm)

Single Chain and non-colocated transmitters								
Band	Mode	Separation Distance (cm)	Output AVG Power (dBm)	Antenna Gain (dBi)	Duty Cycle (%)	EIRP (mW)	FCC Power Density (mW/cm^2)	IC Density (W/m^2)
2.4 GHz	802.11b	20	15.60	3.20	100.0	75.9	0.015	0.15

The device operates above 300 MHz and below 6 GHz with a maximum 0.076 W EIRP. This is less than allowed 2.7 Watts in 2.4GHz band as a mobile device with a minimum separation distance of 20 cm; therefore it is exempt from routine RF Exposure Evaluation under RSS-102.

### Notes:

- 1) For MPE the new KDB 447498 requires the calculations to use the maximum rated power; that power should be declared by the manufacturer, and should not be lower than the measured power. If the power has a tolerance then we also need to check that the measured power is within the tolerance.
- 2) A tolerance value of +1.5 dB was included in the output power values above to cover the output power tolerance of +/-1.5 dB under extreme conditions in the real field as declared by the client.
- 3) The manufacturer configures output power so that the maximum power, after accounting for manufacturing tolerances, will never exceed the maximum power level measured.
- 4) The output power in the tables above is the maximum power per chain among various channels and various modes within the specific band.
- 5) The antenna gain in the tables above is the maximum antenna gain among various channels within the specified band.

## END OF REPORT